

Crystal Structure and Electrical Resistivity of $\text{ZrAg}_{0.46}\text{Al}_{2.54}$

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ABSTRACT: The new $\text{ZrAg}_{0.46}\text{Al}_{2.54}$ ternary compound has been prepared by arc-melting and studied by means of X-ray powder diffraction technique. The structural refinement of $\text{ZrAg}_{0.46}\text{Al}_{2.54}$ was performed by using Rietveld method. The $\text{ZrAg}_{0.46}\text{Al}_{2.54}$ compound crystallizes in the cubic Cu_3Au -type structure with the space group $Pm\bar{3}m$ (No.221) and the lattice parameter of $a = 4.1074$ (1). The structural refinement of $\text{ZrAg}_{0.46}\text{Al}_{2.54}$ leads to the reliability R factors to be $R_p = 0.05$, $R_{wp} = 0.065$, $R_{exp} = 0.039$ and $S = 1.65$, respectively. Electrical resistivity of $\text{ZrAg}_{0.46}\text{Al}_{2.54}$ was also measured between 5 and 300K. Temperature variation of the electrical resistivity of $\text{ZrAg}_{0.46}\text{Al}_{2.54}$ suggests its metallic character. The Debye temperature of $\text{ZrAg}_{0.46}\text{Al}_{2.54}$ is calculated to be $\Theta_D = 361\text{K}$.

KEYWORDS: X-ray diffraction; Crystal structure; Electrical properties; Debye temperature;

1 INSTRUCTIONS

There is very limited investigation on the Al-Ag-Zr system reported in literature. There are ten intermediate phases in the Zr-Al system, i.e. Zr_3Al , Zr_2Al , Zr_5Al_3 , Zr_3Al_2 , Zr_4Al_3 , Zr_5Al_4 , ZrAl , Zr_2Al_3 , ZrAl_2 , and ZrAl_3 , for which homogeneity ranges appear to be quite restricted [1]. The phase equilibrium of the Ag-Al system has been investigated and two compounds Ag_3Al and Ag_2Al were reported [2]. Two tetragonal intermediate phases with the approximate compositions AgZr and AgZr_2 were found in the Ag-Zr systems [3]. Much effort has been done in order to discover new ternary compounds with excellent properties. Fecht and his co-workers studied the sequence of phase transformations induced in the Zr-Al binary system by mechanical alloying of mixed Zr and Al powders [4]. In our recent study, new $\text{ZrAg}_{0.46}\text{Al}_{2.54}$ ternary compound has been found and its crystal structure has been determined by X-ray diffraction (XRD) technique. Electrical resistivity and the Debye temperature of $\text{ZrAg}_{0.46}\text{Al}_{2.54}$ have also been investigated. Here, we report the results.

2 EXPERIMENTAL DETAILS

The sample of $\text{ZrAg}_{0.46}\text{Al}_{2.54}$ with a total mass of 3 g, was prepared by arc-melting of initial pure materials (Zr: 99.9%, Ag: 99.999%, Al: 99.99%)

under high-purity argon atmosphere. The sample of $\text{ZrAg}_{0.46}\text{Al}_{2.54}$ was turned over and remelted three times to reach good homogeneity. The weight loss after melting was found to be less than 0.5%. The homogenizing annealing for $\text{ZrAg}_{0.46}\text{Al}_{2.54}$ was carried out at 900°C for 30 days in an evacuated quartz tube and cooled down to 500°C for 2 days, and then quenched into liquid nitrogen. The sample was ground in an agate mortar and pestle to a particle size of less than $10\mu\text{m}$ and annealed in an evacuated small quartz tube at 500°C for 5 hours, then quenched into liquid nitrogen.

Powder XRD data of $\text{ZrAg}_{0.46}\text{Al}_{2.54}$ were obtained from a Rigaku D/max 2500V diffractometer with a CuK_α ($\lambda = 1.54060\text{\AA}$). The (2θ) scan range was set from 10° to 110° with a step size of 0.02° . The index of the powder XRD data of $\text{ZrAg}_{0.46}\text{Al}_{2.54}$ was carried out by using a Jade5.0 program [5]. Electrical resistivity measurements for $\text{ZrAg}_{0.46}\text{Al}_{2.54}$ were performed in the temperature range of 5-300K by a conventional four-probe method with a voltage resolution of 10^{-7} V .

3 RESULTS AND DISCUSSION

3.1 Crystal structure

The XRD analysis proved the existence of the $\text{ZrAg}_{0.46}\text{Al}_{2.54}$ compound. All of the XRD patterns for $\text{ZrAg}_{0.46}\text{Al}_{2.54}$ were indexed successfully on a cubic structure with a reliability factor F_N to be $F_{30} =$

176.1(12) for the index [6]. The reflection conditions yield three possible space groups: $Pm\bar{3}m$ (No. 221), $P43$ (No. 207) and $P\bar{4}3m$ (No. 215) for the structure of $ZrAg_{0.46}Al_{2.54}$. Each unit cell contains one formula (4 atoms) based on the lattice parameters and the density ($D_m = 5.00 \text{ g/cm}^3$). By careful comparison, it was found that $ZrAg_{0.46}Al_{2.54}$ is isostructural with the Cu_3Au with space group $Pm\bar{3}m$ (No.221) [7], which has the highest symmetry among the three possible space groups. Thus the space group $Pm\bar{3}m$ (No.221) was assigned to $ZrAg_{0.46}Al_{2.54}$. The structure of $ZrAg_{0.46}Al_{2.54}$ was refined by using Rietveld method with the DBWS9411 program [8]. The pseudo-Voigt function was used for the simulation of the peak shapes. The lattice parameters of $ZrAg_{0.46}Al_{2.54}$ obtained by the Jade 5.0 program and the atomic parameters of Cu_3Au [7] were input as the initial values to refine the structural parameters of $ZrAg_{0.46}Al_{2.54}$. A total of 14 parameters, including the lattice constants, full width at half maximum (FWHM), preferred orientation, atomic parameters and thermal parameters were refined. The structural refinement of $ZrAg_{0.46}Al_{2.54}$ leads to the reliability R factors to be $R_p = 0.05$, $R_{wp} = 0.065$, $R_{exp} = 0.039$ and $S = 1.65$, respectively. The reliability R factor expressions for the Rietveld structural refinement are given below.

$$F_N = \frac{1}{\langle 2\theta \rangle} \frac{N_{obs}}{N_{cal}} \quad (1)$$

$$R_p = \frac{\sum |Y_i(obs) - Y_i(calc)|}{\sum Y_i(obs)} \quad (2)$$

$$R_{wp} = \left\{ \frac{\sum \omega_i (Y_i(obs) - Y_i(calc))^2}{\sum \omega_i (Y_i(obs))^2} \right\}^{1/2} \quad (3)$$

$$R_{EXP} = \left[\frac{N - P}{\sum_i \omega_i (Y_i(obs))^2} \right]^{1/2} \quad (4)$$

$$S = R_{WP} / R_p \quad (5)$$

The Rietveld refinement result points to that the $ZrAg_{0.46}Al_{2.54}$ compound adopts the structure of Cu_3Au . The Rietveld refinement result and crystal data for the $ZrAg_{0.46}Al_{2.54}$ compound are presented in Table 1. In the cubic structure of $ZrAg_{0.46}Al_{2.54}$, the Zr atoms are at the 1a positions, while the Ag and Al atoms occupy in the 3c positions (84.5 at.% Al + 15.5 at.% Ag). The refined atomic parameters for $ZrAg_{0.46}Al_{2.54}$ are given in Table 2. In the structure of $ZrAg_{0.46}Al_{2.54}$, the shortest distance of Zr-M (M=Ag, Al) is 2.9044 Å and is reasonable compared to the sum of Zr-M radii. There are 12 nearest atoms in the surrounding of the Zr and M atoms, respectively. The observed, calculated of XRD patterns of $ZrAg_{0.46}Al_{2.54}$ along with their residuals are shown in Fig.1.

3.2 Electrical resistivity

The electrical resistivity of $ZrAg_{0.46}Al_{2.54}$ was measured in the temperature range 5-300K with a voltage resolution of 10^{-7} V. The temperature dependence of the electrical resistivity for $ZrAg_{0.46}Al_{2.54}$ is presented in Fig. 2. The electrical resistivity of $ZrAg_{0.46}Al_{2.54}$ is observed to fall from 0.1181 to 0.098 $\mu\Omega/\text{cm}$ between room temperature and 5K. In 5-300K, the resistivity of $ZrAg_{0.46}Al_{2.54}$ decreases approximately linearly with the decrease of temperature pointing out its metallic-like behavior.

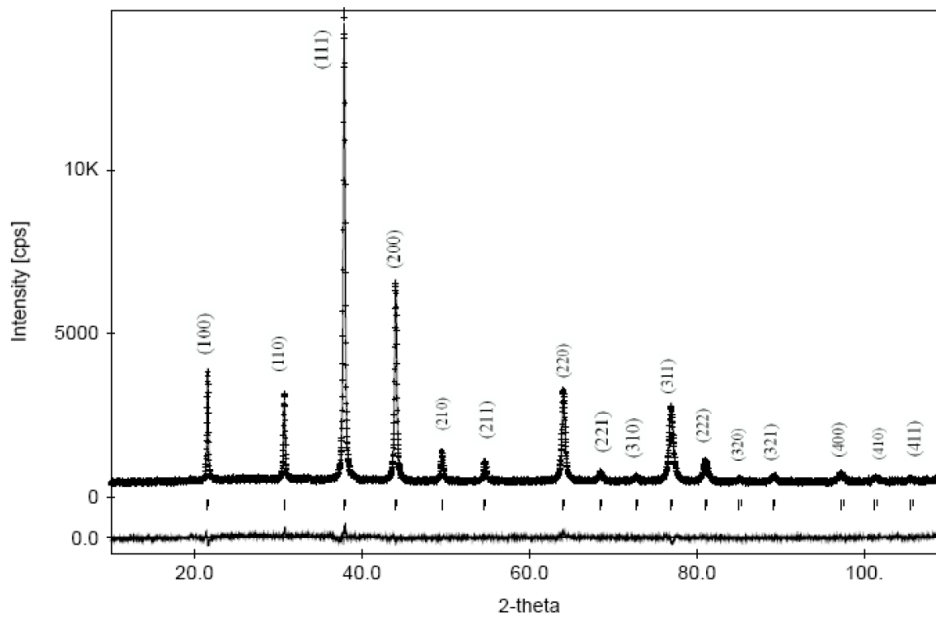


Fig. 1. Powder XRD patterns for $ZrAg_{0.46}Al_{2.54}$.

Table 1 Crystal data and lattice parameters for $\text{ZrAg}_{0.46}\text{Al}_{2.54}$

Formula	$\text{ZrAg}_{0.46}\text{Al}_{2.54}$
Space group	$Pm\bar{3}m$ (No.221)
a (Å)	a = 4.1074 (1)
Unit cell volume(Å ³)	69.295
Formula units per unit cell	1
Calculated density (g/cm ³)	5.030
F _N	F ₃₀ = 176.1(12)
R _p	0.05
R _{wp}	0.065
R _{exp}	0.039
S	1.65

Table 2. The atomic parameters for the $\text{ZrAg}_{0.46}\text{Al}_{2.54}$

Atoms	site	x	y	z	Occ.	B _{eq} (Å ²)
Zr	1a	0	0	0	1	0.459
M	3c	0	0.5	0.5	0.845 Al + 0.155 Ag	0.558

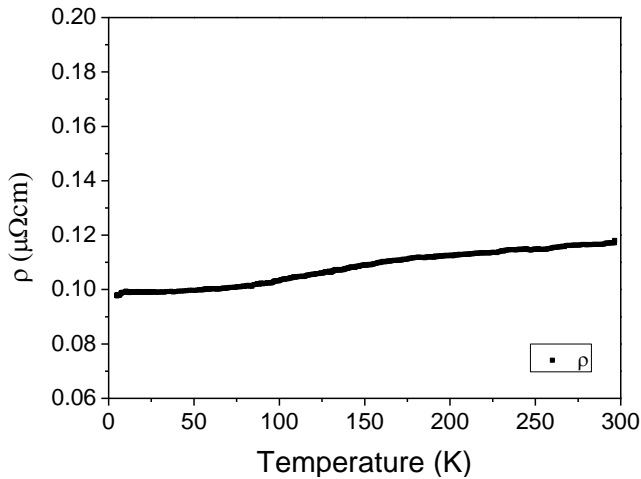


Fig. 2. Temperature dependence of the electrical resistivity for $\text{ZrAg}_{0.46}\text{Al}_{2.54}$.

3.3 Debye Temperature

As the characteristic temperature of vibration, the Debye temperature Θ_D is found to be closely related to the temperature factor of each component atom of a compound (here, B_{Zr} , B_{Ag} and B_{Al} for $\text{ZrAg}_{0.46}\text{Al}_{2.54}$). According to the Debye approximation[9 – 13], the following relationship can be obtained:

$$\frac{1}{4} (m_{\text{Zr}} B_{\text{Zr}} + 3 \times (0.843 m_{\text{Al}} B_{\text{Al}} + 0.157 m_{\text{Ag}} B_{\text{Ag}})) = \frac{6h^2 T}{k \Theta_D^2} \left\{ \Phi(x) + \frac{x}{4} \right\} \quad (6)$$

where $x = \Theta_D / T$, h is Planck's constant, k is Boltzmann's constant, T is the experimental

temperature, and $\Phi(x)$ is the Debye integral function, which can be calculated from:

$$\Phi(x) = \frac{1}{x} \int_0^x \frac{y}{e^y - 1} dy \quad (7)$$

Further define:

$$G = \frac{kT}{24h^2} (m_{\text{Zr}} B_{\text{Zr}} + 3 \times (0.843 m_{\text{Al}} B_{\text{Al}} + 0.157 m_{\text{Ag}} B_{\text{Ag}})) \quad (8)$$

Then Eq. (1) can be rewritten as

$$\Phi(x) + \frac{x}{4} = Gx^2 \quad (9)$$

The value of G can be calculated from Eq. (8) to be $G = 0.712$ for $\text{ZrAg}_{0.46}\text{Al}_{2.54}$. By plotting the two curves which represent $y_1 = \Phi(x) + x/4$ and $y_2 = Gx^2$, as shown in Fig. 3, the value of $x = 1.2055$ was obtained from the point where the two curves meet. Then the Debye temperature of $\text{ZrAg}_{0.46}\text{Al}_{2.54}$ can easily be calculated to be $\Theta_D = T_x = 361\text{K}$.

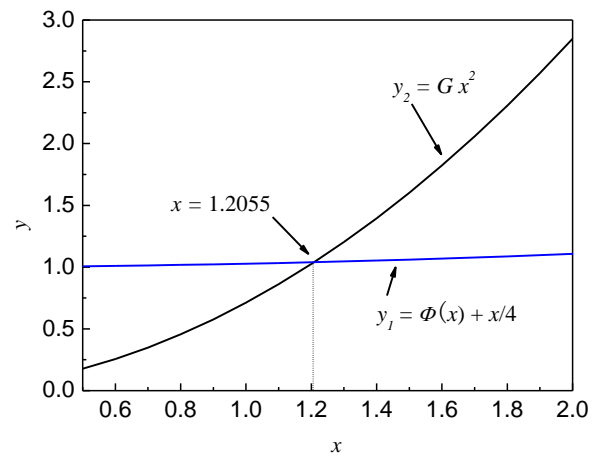


Fig. 3. Calculation of Θ_D by Debye approximation.

4 CONCLUSION

The crystal structure of the new $\text{ZrAg}_{0.46}\text{Al}_{2.54}$ ternary compound was determined by XRD technique and its structure was successfully refined by using Rietveld method. The $\text{ZrAg}_{0.46}\text{Al}_{2.54}$ compound crystallizes in an cubic Cu_3Au -type structure, space group $Pm\bar{3}m$ (No.221) with $a = 4.1074$ (1) Å. The reliability factor, F_N , for the index of $\text{ZrAg}_{0.46}\text{Al}_{2.54}$ is $F_{30} = 176.1(12)$. The reliability R-factors of Rietveld refinement are $R_p = 0.05$, $R_{wp} = 0.065$ and $R_{exp} = 0.039$, respectively. Measurement of the electrical resistivity of $\text{ZrAg}_{0.46}\text{Al}_{2.54}$ from 5-300K suggests its metallic character. The Debye temperature of $\text{ZrAg}_{0.46}\text{Al}_{2.54}$ is calculated to $\Theta_D = 361\text{K}$ from the temperature factors of Rietveld refinement.

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